

CX11LHG AT CRYSTAL

16 MHz to 50 MHz High Shock, Ultra Low Profile, Ultra-Miniature AT Quartz Crystal

DESCRIPTION

CX11LHG is a high performance quartz crystal designed to survive the most extreme shock and high vibration application environments. Low acceleration sensitivity and low aging performance meets the most demanding requirements. Available with tight calibration tolerances and high stability over temperature.



PACKAGE DIMENSIONS

FEATURES

- Mechanical shock survivability up to 75,000 g
- Ultra-low profile typical height of 0.5 mm
- Low acceleration sensitivity available
- Hermetically sealed ceramic package
- Excellent aging characteristics
- Full military testing available
- Designed, manufactured and tested in the USA

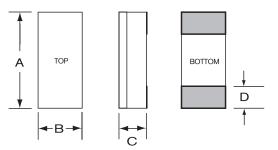
APPLICATIONS

Industrial & Communications

- Down-hole Data Recorder
- Process Control
- Environmental Control
- Engine Control
- Telemetry
- Ruggedized Instrumentation
- Automotive Control

Military & Aerospace

- Smart Munitions
- Timing Devices (Fuzes)
- Surveillance Devices
- Missile Telemetry
- Ruggedized Communications
- Aviation Equipment

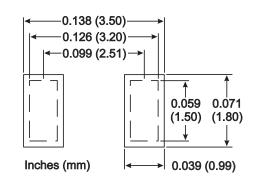


	TYPICAL		MAXI	MAXIMUM	
DIM	inches	mm	inches	mm	
А	0.127	3.20	0.135	3.43	
В	0.060	1.50	0.068	1.73	
С		see below	/		
D	0.028	0.71	0.037	0.94	

THICKNESS (DIM C)

Termination	Typical		Maximum		
	inches	mm	inches	mm	
SM1	0.020	0.51	0.023	0.59	
SM2/SM4	0.021	0.53	0.024	0.60	
SM3/SM5	0.023	0.58	0.025	0.63	

SUGGESTED LAND PATTERN



STATEK CORPORATION 512 N. MAIN ST., ORANGE, CA 92868 714-639-7810 FAX: 714-997-1256 www.statek.com

SPECIFICATIONS

Specifications are typical at 25°C unless otherwise noted. Spe-cifications are subject to change without notice.

Fundamental Frequency ¹	<u>16.0 MHz</u>	<u>24.0 MHz</u>	<u>32.0 MHz</u>	
Motional Resistance $R_1(\Omega)$	85	30	25	
Motional Capacitance C_1 (fF) 1.5	1.6	1.9	
Quality Factor Q (k)	80	150	110	
Shunt Capacitance C_0 (pF)	0.7	0.7	0.9	
Calibration Tolerance ²	± 100 to ± 30 ppm, or tighter as required			
Load Capacitance	10 pF (unless specified otherwise)			
Drive Level	200 µW M/	ΑX		
Frequency-Temperature	± 50 ppm to ± 10 ppm (Commercial)			
Stability ^{2,3}	± 50 ppm to ± 20 ppm (Industrial)			
	±100 ppm	to ±30 ppm ((Military)	
Aging, first year	5 ppm MAX	<		
Shock, survival	up to 75,000 g, 0.3 ms, 1/2 sine			
Vibration, survival ⁴	20 g, 10-2	,000 Hz swej	ot sine	
Operating Temp. Range		70°C (Comr	,	
		35°C (Indus	·	
	-55°C to +	125°C (Milita	ry)	
Storage Temp. Range	-55°C to +	125°C		
Max Process Temperature	260°C for 2	20 sec.		

1. For frequencies above 50 MHz contact factory.

2. Other tolerances available. Contact factory.

3. Does not include calibration tolerance. The characteristics of the frequency stability over

temperature follow that of the AT thickness-shearmode.

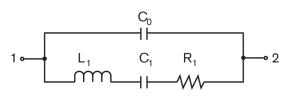
4. Per MIL-STD-202G, Method 204D, Condition D. Random vibration testing also available.

TERMINATIONS

<u>Designation</u>	<u>Termination</u>
SM1	Gold Plated
SM2	Solder Plated
SM3	Solder Dipped
SM4	Solder Plated (Lead Free)
SM5	Solder Dipped (Lead Free)

Max Process Temperature 260°C for 20 sec.

EQUIVALENT CIRCUIT



 R_1 Motional Resistance L_1 Motional Inductance C_1 Motional Capacitance C_0 Shunt Capacitance

PACKAGING OPTIONS

- Tray Pack
- 12 mm tape, 7"or 13" reels Per EIA 481 (see Tape and Reel data sheet 10109)

SGS

HOW TO ORDER LOW PROFILE CX11LHG AT CRYSTALS

